

# **Notice of References Cited**

Application/Control No.  
09/911,892

Applicant(s)/Patent Owner(s)  
Donig et al.

Examiner  
John Kim

Art Unit  
1723

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

* #	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
x A	4,869,286	9/1989	Williams et al.		
x B	5,311,899	5/1994	Isayama et al.		
x C	5,540,265	7/1996	Polaschegg et al.		
x D	5,572,992	11/1996	Kankkunen et al.		
x E	5,583,948	12/1996	Shibayama		
x F	5,925,014	7/1999	Teeple, Jr.		
x G	5,997,502	12/1999	Reilly et al.		
H	4,895,657	1/1990	Polaschegg	210	647
I	6,017,318	1/2000	Gauthier et al.	600	578
J					
K					
L					
M					

## **FOREIGN PATENT DOCUMENTS**

* #	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>	
x N	0,311,848 A2	4/1989	Europe			
x O	0,575,970	12/1993	Europe			
x P	WO 92/11046	7/1992	PCT			
x Q	WO 96/25214	8/1996	PCT			
R						
S						
T						

## **NON-PATENT DOCUMENTS**

* #	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages				
U					
V					
W					
X					

<sup>1</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

<sup>2</sup> Dates in MM-YYYY format are publication dates.

<sup>3</sup> Classifications may be U.S. or foreign.